

11/03

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 245669US2S		SERIAL NO. 10/716,565 NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Ryu OGIWARA			
				FILING DATE HEREWITH 11/20/03		GROUP 2827	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
TP	AA	5,661,730	08/26/97	Sanjay MITRA, et al.			
TP	AB	5,991,189	11/23/99	Tohru MIWA			
TP	AC	5,822,237	10/13/98	Dennis R. WILSON, et al.			
TP	AD	5,903,492	05/11/99	Daisaburo TAKASHIMA			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
TP	AO	2000-268599	09/29/00	Japan		X	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
TP	AW	Joseph M. BENEDETTO, et al., "Effects of operating conditions on the fast-decay component of the retained polarization in lead zirconate titanate thin films", J.APPL PHYS. 75 (1), January 1, 1994					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Trong Phan</i>					Date Considered <i>4/28/05</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							